

Energy Digitization for CEPC Crystal ECAL

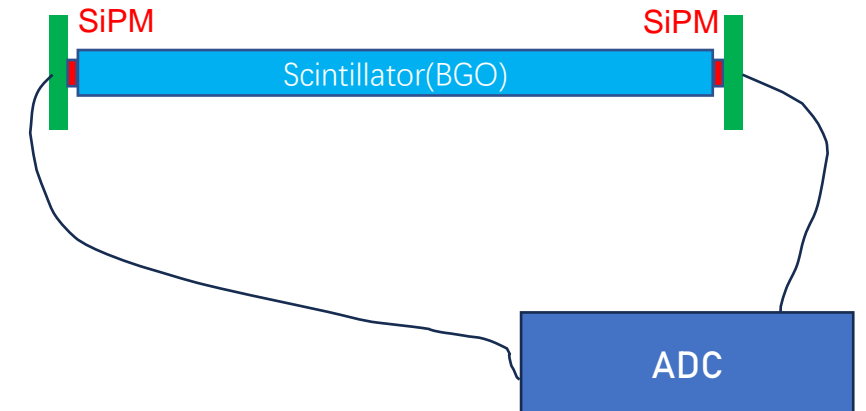
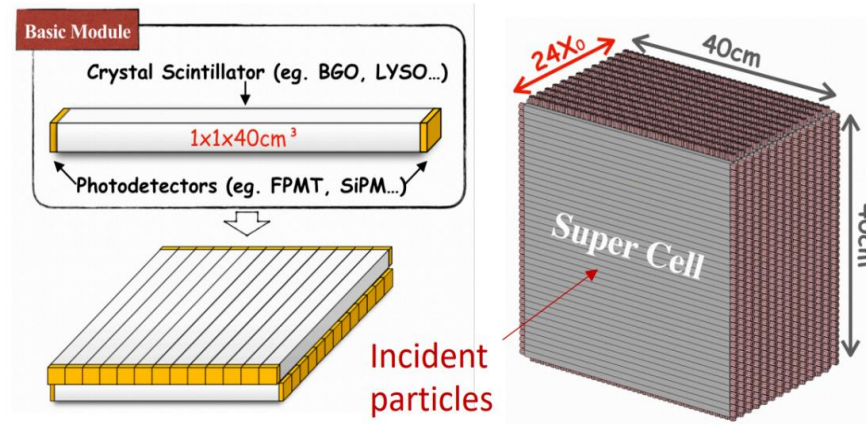
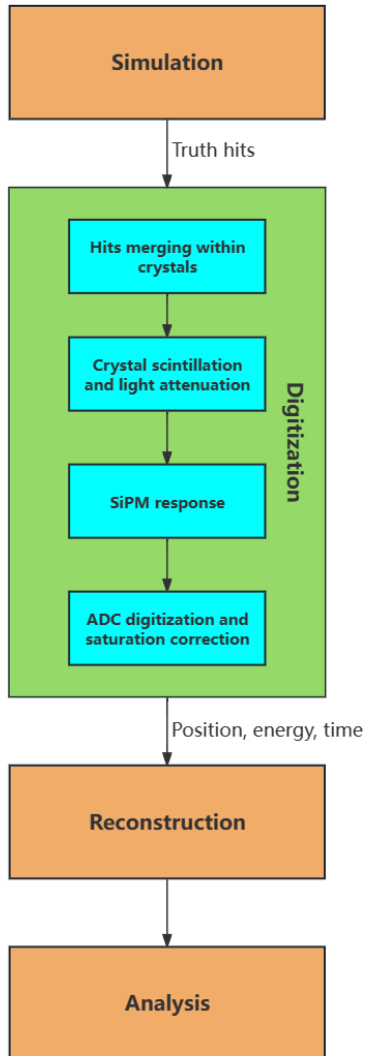
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- Realistic digitization model dedicated to CEPC Crystal ECAL
 - Position(x, y, z): determined by crystal alignment
 - Energy(hit energy → detected energy): parameterized behaviors of scintillator & SiPM & ADC
 - Scintillation digitization: Crystal light yield and uniformity
 - SiPM digitization: SiPM response and saturation correction
 - ADC digitization: ADC precision, noise and dynamic range
 - Time: depends on TDC and time resolution of crystal unit

- Energy deposit and scintillation

- A fluctuation of 1% in crystals' light yield: Gaussian sampling

$$LY = Gaus(LY_{MIP}, 0.01 \cdot LY_{MIP})$$

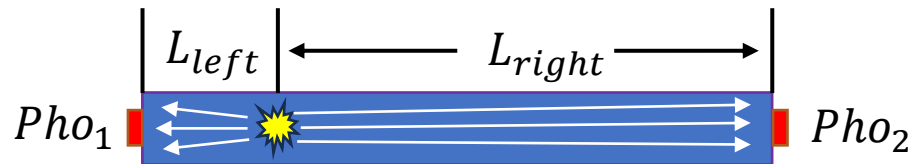
- Fluctuation in scintillation(energy \rightarrow photons): Poisson sampling

$$N_{ph} = Poisson(E_{dep}/E_{MIP} \cdot LY)$$

- Light propagates to both ends: ratio of exponential decay

$$\epsilon N_{In,l/r} = R_{l/r} \cdot N_{ph}$$

Assume the light measured at both ends follows exponential decay.



$L_A = 8000 \text{ mm}$, max response non-uniformity along crystal bar is $\sim 5\%$

$$N_{ph1} = \frac{e^{-\frac{L_{left}}{L_A}}}{e^{-\frac{L_{left}}{L_A}} + e^{-\frac{L_{right}}{L_A}}} \cdot N_{ph}$$

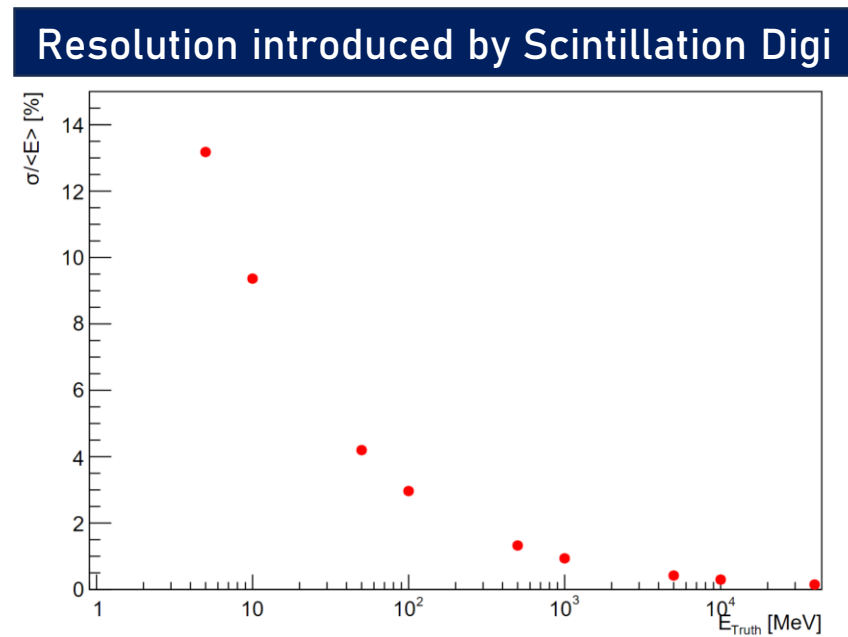
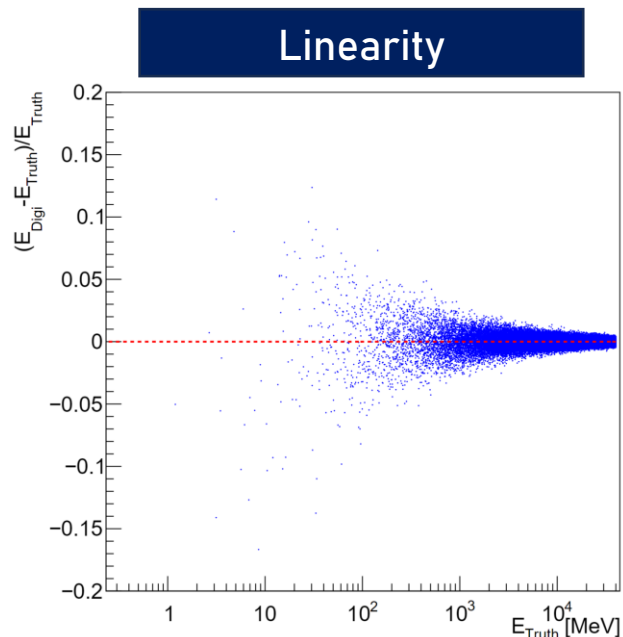
\downarrow
 R_l

MIP light yield (p.e./MIP)	200
MIP energy (MeV/MIP)	8.9
LY calibration precision	1%
L_A (mm)	8000

Performance Check: Scintillation



- Only check for the algorithm for single-end readout(LY=100p.e./MeV). No detector simulation and attenuation here
- Linearity of scintillation digitization is no problem
- ~1% resolution at 1GeV



Digitization: SiPM



- SiPM response and its fluctuation were obtained from simulation, which is based on **40cm BGO and SiPM with 6 μ m pixel**

- SiPM response: response function and Gaussian sampling

$$\langle N_{Det} \rangle = f(\epsilon N_{In})$$

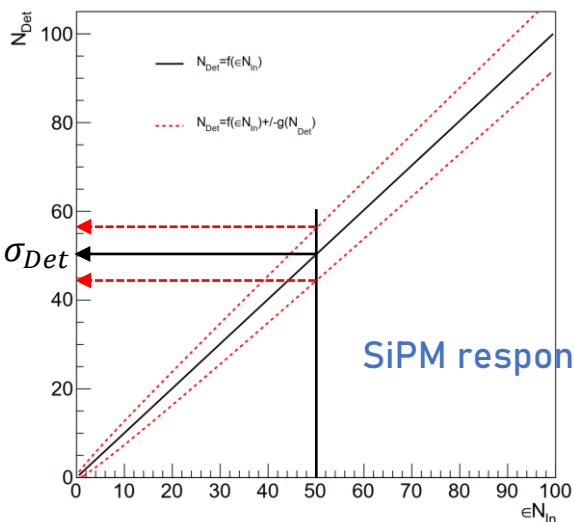
$$\sigma_{Det} = g(\epsilon N_{In})$$

- Saturation correction (**after ADC Digi**): inverse form of response function

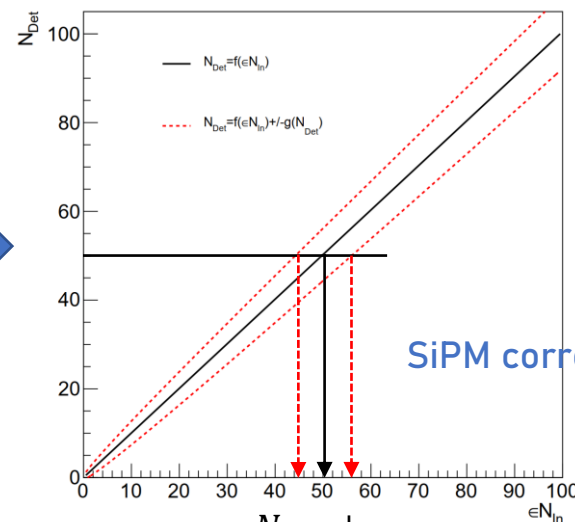
$$\langle N_{Rec} \rangle = f^{-1}(N_{Det})$$

$$\sigma_{Rec} = |a^{-1}/b^{-1}(N_{Det}) - N_{Rec}|$$

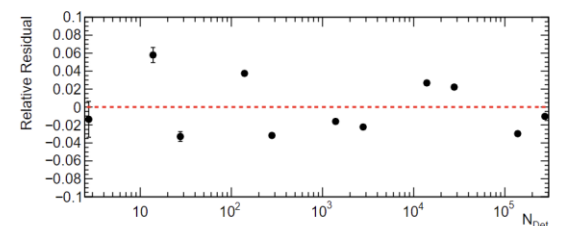
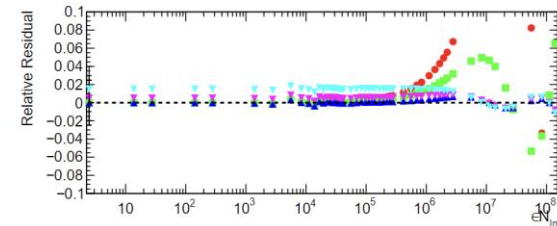
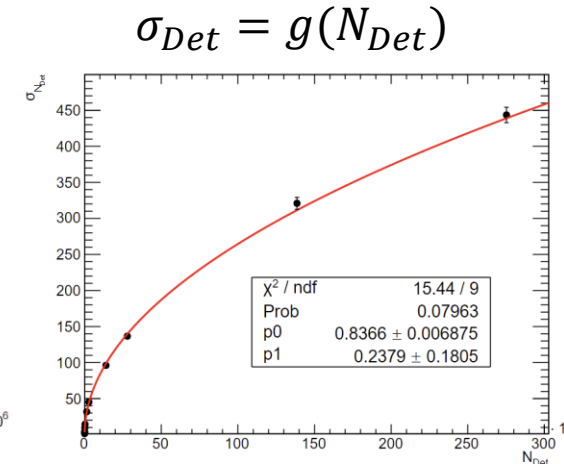
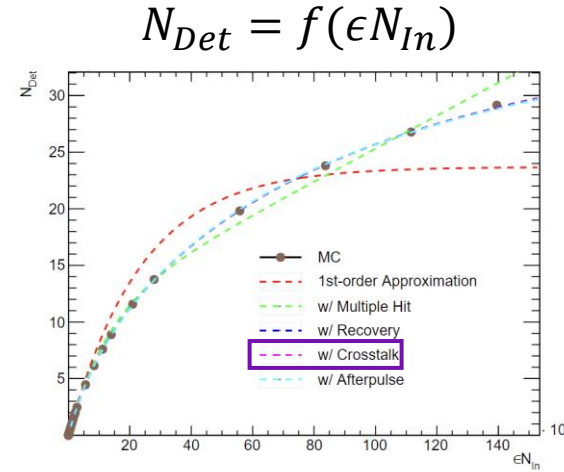
$$a/b = f \text{ +/- } g$$



SiPM response



SiPM correction



$$f(x) = a \frac{(x+b\varphi)\varphi^2}{x+c\varphi}, \quad \varphi = (1 - e^{-x/d})$$

$$g(x) = p_0 \sqrt{x + p_1}$$

[arxiv.1510.01102](https://arxiv.org/abs/1510.01102)

Performance Check: SiPM



0.5% crosstalk

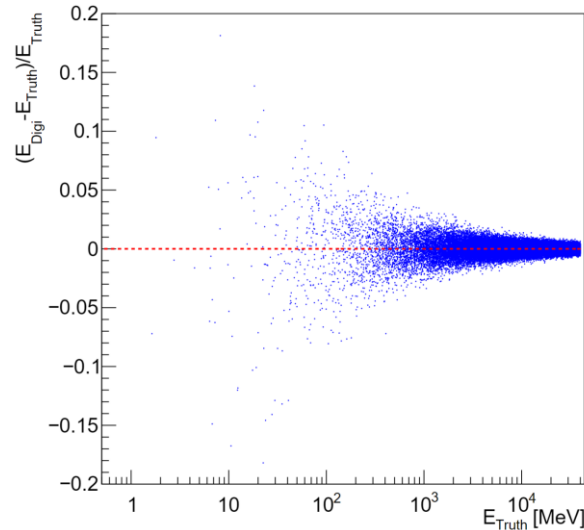
N_{Rec} follows an asymmetric Gaussian distribution

Response

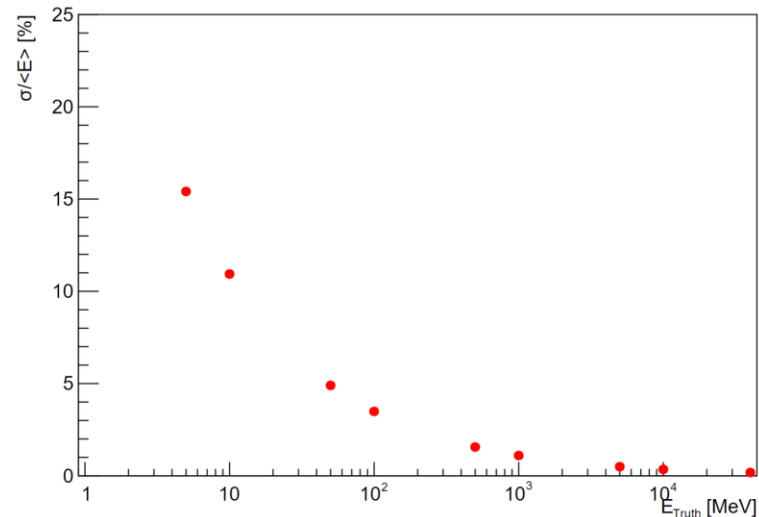
Correction

ϵN_{In}	10	100	1,000	10,000	100,000	500,000
$\langle N_{Det} \rangle$	10.05	100.5	1,005	10,045.3	100,037	491,159
σ_{Det}	2.66	8.33	26.3	83.14	262.3	581.02
$\langle N_{Rec} \rangle$	10	100	1,000	10,000	100,000	500,000
$\sigma_{Rec,-/+}$	2.32/3.00	7.96/8.65	25.89/26.58	82.68/83.37	264.38/265.08	613.48/614.27

SiPM Linearity (after correction)



Resolution introduced by SiPM Digitization



σ_{Rec} is very close to σ_{Det} when $\epsilon N_{In} < 100,000$, and the asymmetry can almost be ignored

Performance Check: SiPM Verbose



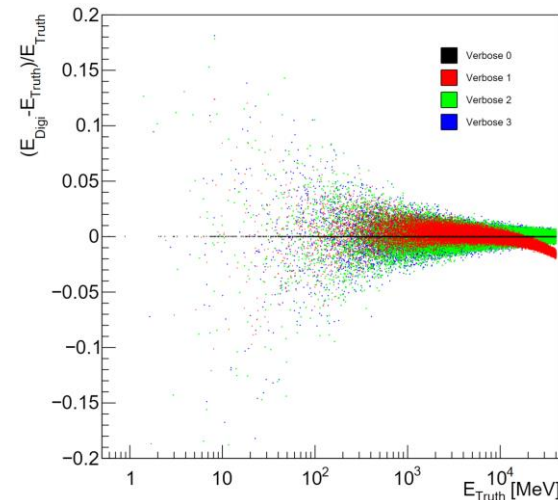
SiPM Digitization Verbose in CEPCSW

fast → slow

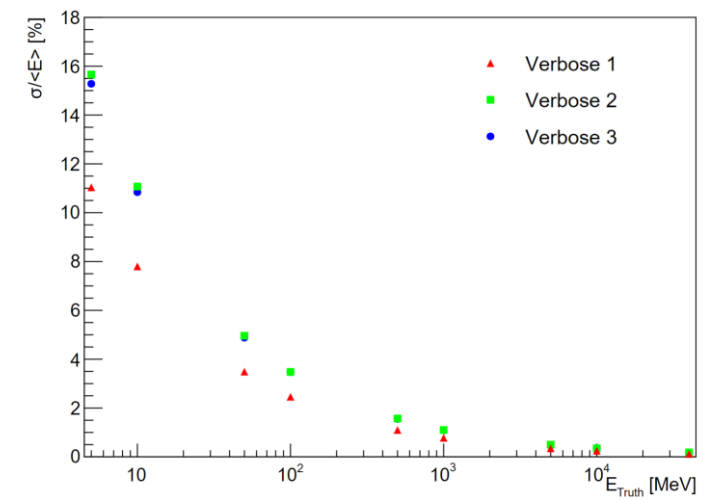
Verbose	0	1	2	3
Description	❌ response ❌ correction	✅ response ❌ correction	✅ response ✅ simple correction	✅ response ✅ full correction

- Verbose 0: no SiPM related effect in digitization
- Verbose 1: SiPM response follows the function $f(x)$, while no correction on saturation
- Verbose 2: SiPM response follows the function $f(x)$, and a simple correction on saturation with $\sigma_{Rec} = \sigma_{Det}$
- Verbose 3: SiPM response follows the function $f(x)$, and a full correction on saturation

SiPM Linearity



Resolution introduced by SiPM Digitization



Verbose-1 without saturation correction has better resolution but a 2% non-linearity at 40GeV.

Digitization: ADC

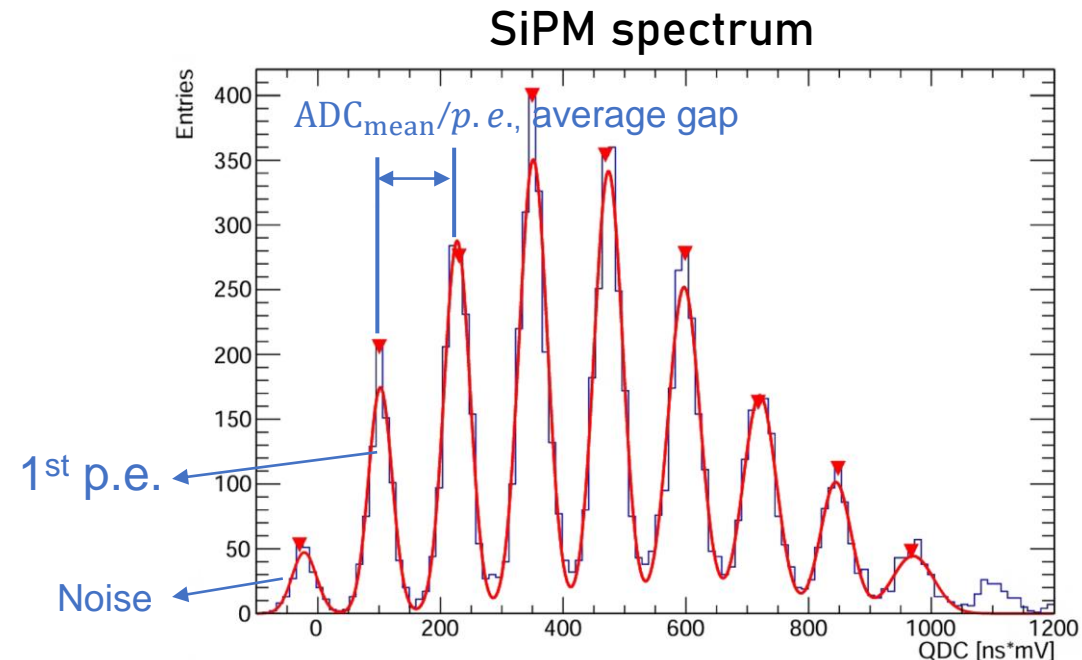
- ADC digitization: multi-gains to expand dynamic range

- 4096 ADC counts, 3 gains
- $NPE \rightarrow ADC$: Gaussian sampling

$$\langle ADC \rangle = NPE \cdot \langle ADC \rangle_{SPE}$$

$$\sigma = \sqrt{NPE \cdot \sigma_{SPE}^2 + \sigma_{Noise}^2}, \quad \sigma_{SPE} = \sqrt{\sigma_{1st}^2 - \sigma_{Noise}^2}$$

- Precision 0.2%: Gaussian sampling
- Switch at 4000ADC for Gain-1 and Gain-2
- $ADC(\rightarrow SiPM \text{ correction}) \rightarrow \text{Energy}$
- Energy threshold: 0.05MIP

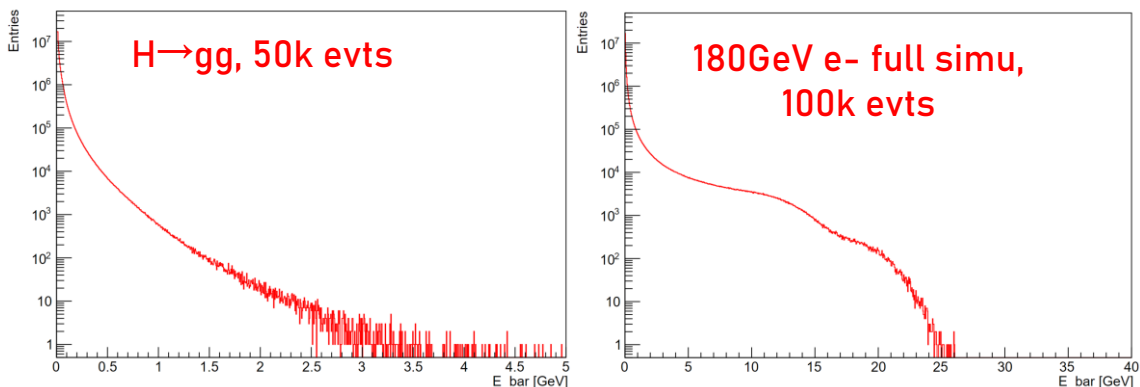


	Gain-1	Gain-2	Gain-3
$\langle ADC \rangle_{SPE}$	25	0.36	0.009
σ_{SPE} (ADC)	1.5	0.021	0.00052
σ_{Noise} (ADC)	5	5	5
Switching (ADC)	4000	4000	-
Energy range	0~1.6MIP	1.6~112MIP	112~4586MIP

14MeV

997MeV

40,819MeV



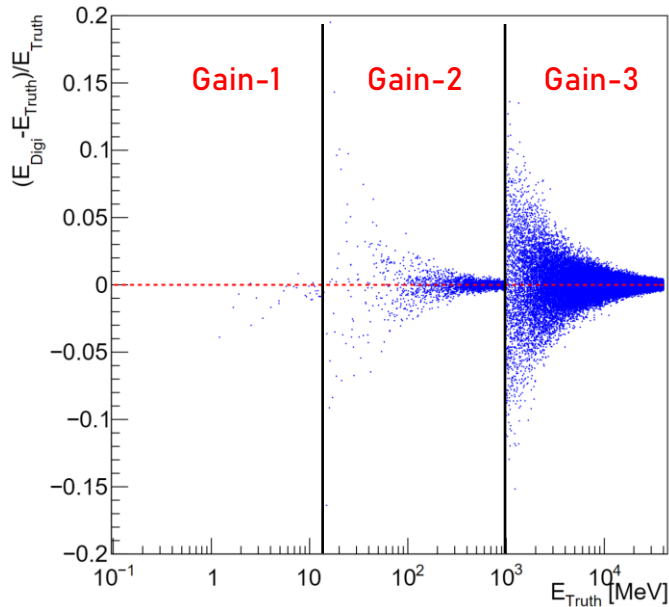
Performance Check: ADC



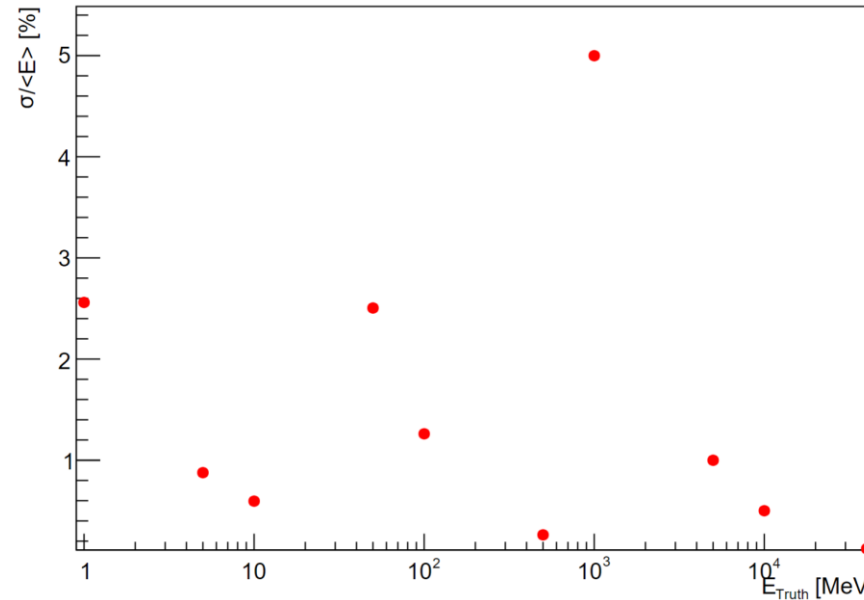
- Linearity of ADC digitization is no problem
- The resolution has a drop after switching points
 - Need to be careful when setting the range. Since the Gain-2 is designed to cover the energy range that most possibly deposited in crystal bars
- S/N is a ideal, difficult to be achieved for SiPM with 6 μ m pixel

	÷ 70	÷ 40	
	Gain-1	Gain-2	Gain-3
$\langle ADC \rangle_{SPE}$	25	0.36	0.009
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Energy range	0~1.6MIP	1.6~112MIP	112~4586MIP
	14MeV	997MeV	40,819MeV

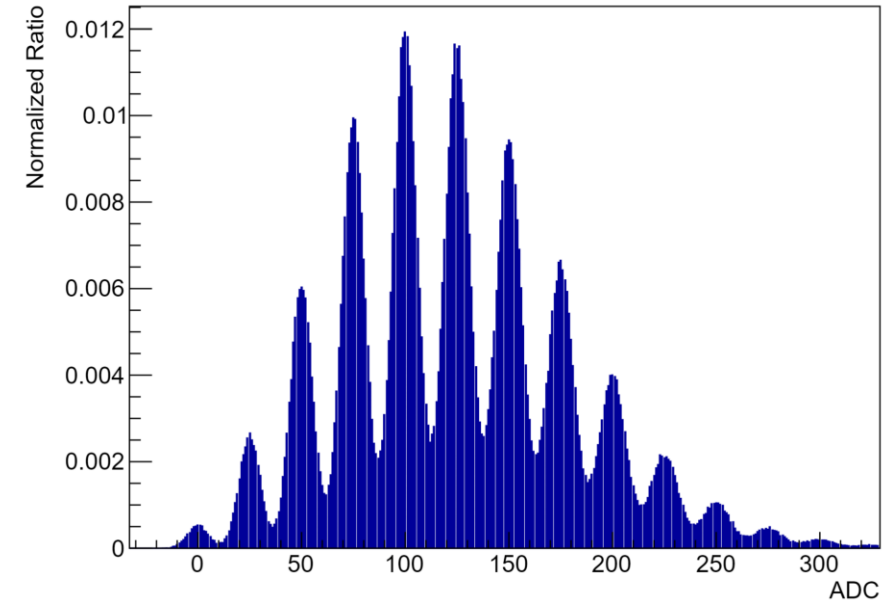
ADC Linearity



Resolution introduced by ADC digitization



Low energy spectrum in Gain-1

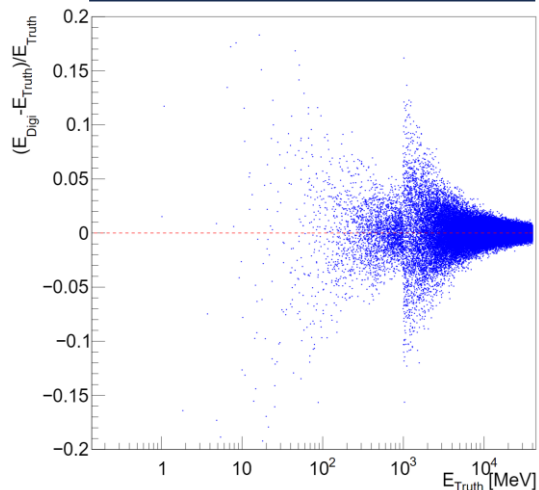


Performance: Total Effects

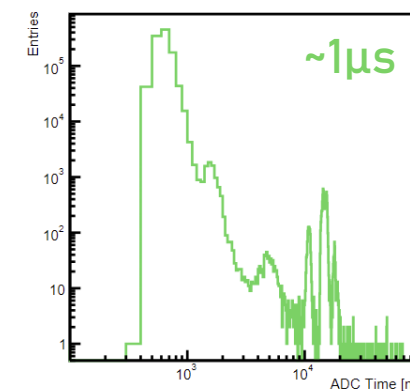
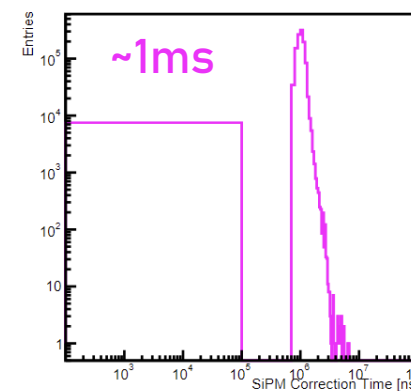
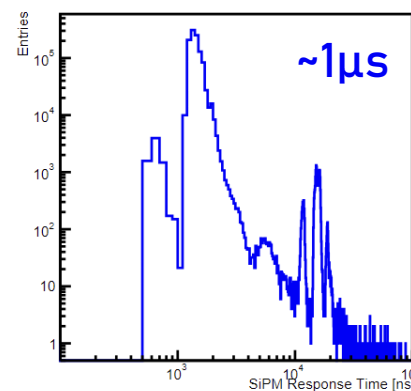
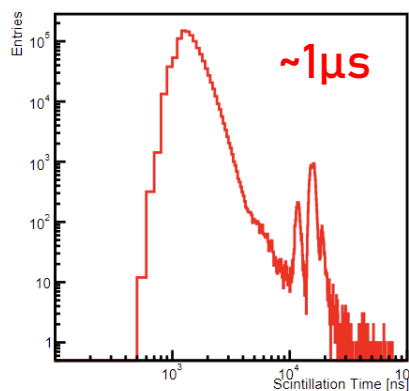


		Gain-1		Gain-2			Gain-3			
		0MeV	14MeV				997MeV	40819MeV		
	Energy (MeV)	5	10	50	100	500	1000	5000	10000	40000
Scintillation	$\sigma/\langle E \rangle$ (%)	13.18	9.36	4.19	2.96	1.32	0.94	0.42	0.30	0.15
SiPM	$\sigma/\langle E \rangle$ (%)	15.28	10.84	4.88	3.47	1.55	1.09	0.49	0.35	0.18
ADC	$\sigma/\langle E \rangle$ (%)	0.88	0.60	2.50	1.26	0.26	5.00	1.00	0.50	0.12
$1\oplus 2\oplus 3$	$\sigma/\langle E \rangle$ (%)	20.20	14.33	6.90	4.73	2.05	5.20	1.19	0.68	0.26
Total	$\sigma/\langle E \rangle$ (%)	19.77	14.20	6.91	4.74	2.05	4.20	1.19	0.68	0.26

Digitization Linearity

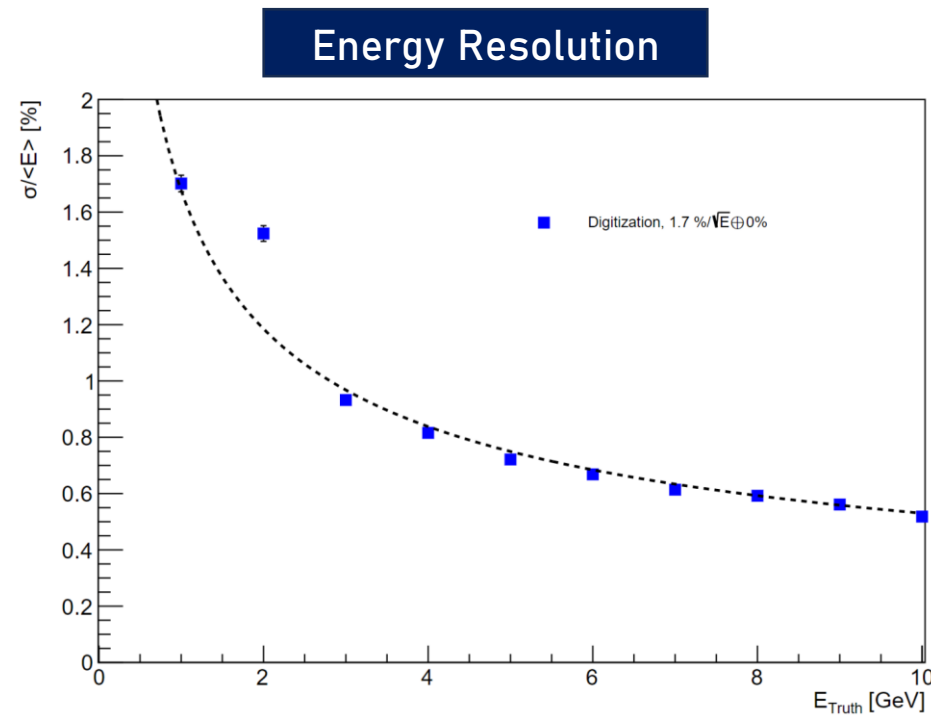
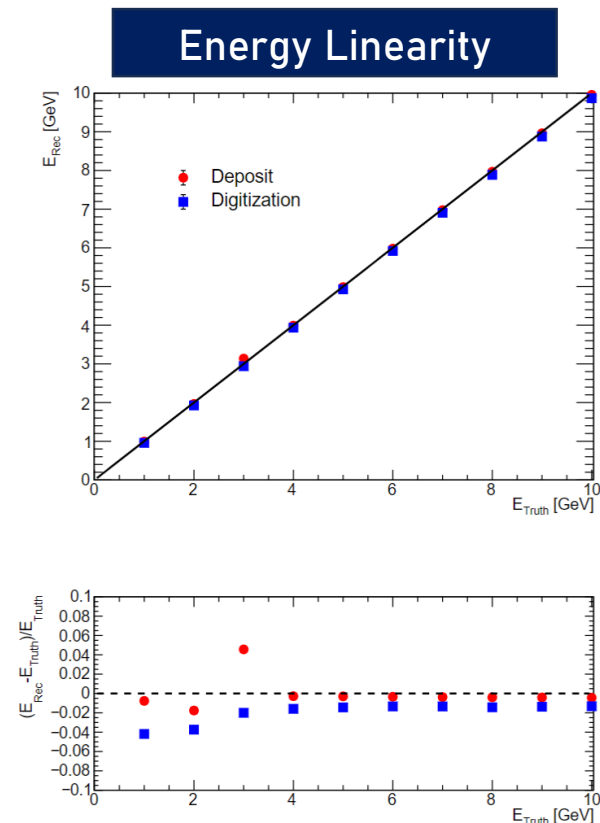


Time consumption: 1~2ms per event, dominated by SiPM correction(Verbose-3)



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- <5% energy leakage at low energy region because of 0.05MIP threshold
- $\sim 1.7\%/\sqrt{E}$ energy resolution with 1~10GeV electron after digitization



- A realistic digitization model combined with behaviors of scintillator, SiPM and ADC is built. By decoupling the contribution from each process, we conclude that the SiPM resolution dominates in low energy region ($<1\text{ GeV}$), while the ADC resolution after the switching points dominates in high energy region ($>1\text{ GeV}$).
- The dynamic range still needs to be optimized. To make sure the capability of source calibration at high gain and covering most physical processes in middle gain.



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Backup

S/N of ADC

- Digitization only with: scintillation fluc + SPE sigma + ADC noise
- Input: 5 photons with Poisson sampling
- $\langle ADC \rangle_{SPE} / \sigma_{SPE}$ should be > 10 , while $\langle ADC \rangle_{SPE} / \sigma_{Noise}$ should be > 3

Reference: SiPMs calibrated with oscilloscope and pre-amplifier

	S14160-3010PS	S13360-3025CS
$\langle QDC \rangle_{SPE}$	292	124
σ_{SPE} (QDC)	9.25	7.5
σ_{Noise} (QDC)	67	18.5

$\langle ADC \rangle_{SPE}$	5
σ_{SPE} (ADC)	2.5
σ_{Noise} (ADC)	3

$\langle ADC \rangle_{SPE}$	10
σ_{SPE} (ADC)	1
σ_{Noise} (ADC)	3

$\langle ADC \rangle_{SPE}$	15
σ_{SPE} (ADC)	1
σ_{Noise} (ADC)	3

